X-Ray Diffraction for the 21st Century



EQUINOX, a comprehensive range of Real Time X-Ray Diffractometers







Our technology...

- ☐ Several X-Ray Diffraction systems
- ☐ Real time detection with PSD type detector
- \square Simultaneous data acquisition up to 120°/20
- \square High resolution up to 0.05°/20
- \square Minimal acquisition time for $120^{\circ}/2\theta = 1$ sec
- ☐ Multi axis goniometer with real time detection
- ☐ Microdiffraction down to 10 µm beam
- ☐ Monochromatic optics
- ☐ Various sample holders
- ☐ Variable temperature & atmosphere chambers
- ☐ Ergonomic data acquisition & treatement software

... to serve all your applications

- ☐ Mineralogy, Organic compounds, Oxides, ...
- ☐ Environmental
- ☐ Mining (cements,phosphates, ...)
- ☐ Pharmaceutical, Cosmetics industry
- ☐ Metallurgy
- ☐ Microelectronics
- ☐ Etc.

Interested in one of these systems?

EQUINOX 100 Stand alone benchtop XRD

EQUINOX 1000 Benchtop XRD

EQUINOX 2000 Routine XRD

EQUINOX 3000 Research XRD

EQUINOX 3500 High Resolution Powder XRD

EQUINOX 5000 2 circle high resolution XRD

EQUINOX 5500 2 circle very high resolution XRD

EQUINOX 6000 4 circle texture/stress XRD

Or maybe by another technique?

SWAXS SAXS WAXS instrumentation

Laue XRD Laue diffraction by back reflection PRECIX Residual stress measurement robot

Xsolo Residual stress portable system

Combined Technique Instrument

XRD + DRIFT and/or XRF and/or Raman

+ in-situ chamber

You need more informations? Contact us now!

Our team is here to listen to your ideas and to work with you to determine the best technical solution to satisfy your research goals.

T + 33 (0)2 3880 4545 F + 33 (0)2 3880 0814 info@inel.fr

INEL S.A.S., Z.A. C.D. 405, 45410 Artenay - France

www.inel.fr